## FDP5N50U / FDPF5N50UT

N-Channel MOSFET, FRFET
500V, 4A, $2.0 \Omega$

## Features

- $R_{D S(o n)}=1.65 \Omega$ ( Typ.) @ $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=2 \mathrm{~A}$
- Low gate charge ( Typ. 11nC)
- Low Crss (Typ. 5pF)
- Fast switching
- $100 \%$ avalanche tested
- Improved dv/dt capability
- RoHS compliant


## Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DOMS technology.

This advance technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutationmode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.

MOSFET Maximum Ratings $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise noted ${ }^{\star}$

| Symbol |  | Parameter |  | FDP5N50U | FDPF5N50UT | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {DSS }}$ | Drain to Source Voltage |  |  | 500 |  | V |
| $\mathrm{V}_{\text {GSS }}$ | Gate to Source Voltage |  |  | $\pm 30$ |  | V |
| $I_{\text {D }}$ | Drain Current | -Continuous ( $\mathrm{T}_{\mathrm{C}}=25$ |  | 4 | 4* | A |
|  |  | -Continuous ( $\mathrm{T}_{\mathrm{C}}=10$ |  | 2.4 | 2.4* |  |
| $\mathrm{I}_{\text {DM }}$ | Drain Current | - Pulsed | (Note 1) | 16 | 16* | A |
| $\mathrm{E}_{\text {AS }}$ | Single Pulsed Avalanche Energy |  | (Note 2) | 216 |  | mJ |
| $\mathrm{I}_{\text {AR }}$ | Avalanche Current |  | (Note 1) | 4 |  | A |
| $\mathrm{E}_{\text {AR }}$ | Repetitive Avalanche Energy |  | (Note 1) | 8.5 |  | mJ |
| dv/dt | Peak Diode Recovery dv/dt |  | (Note 3) | 4.5 |  | V/ns |
|  | Power Dissipation | $\left(\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}\right)$ |  | 85 | 28 | W |
| D |  | - Derate above $25^{\circ} \mathrm{C}$ |  | 0.67 | 0.22 | W/ ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {STG }}$ | Operating and Storage Temperature Range |  |  | -55 to +150 |  | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{L}}$ | Maximum Lead Temperature for Soldering Purpose, $1 / 8$ " from Case for 5 Seconds |  |  | 300 |  | ${ }^{\circ} \mathrm{C}$ |

## Drain current limited by maximum junction temperature

Thermal Characteristics

| Symbol | Parameter | FDP5N50U | FDPF5N50UT | Units |
| :--- | :--- | :---: | :---: | :---: |
| $\mathrm{R}_{\theta \mathrm{JC}}$ | Thermal Resistance, Junction to Case | 1.4 | 4.5 |  |
| $\mathrm{R}_{\theta \text { CS }}$ | Thermal Resistance, Case to Sink Typ. | 0.5 | - |  |
| $\mathrm{R}_{\theta \mathrm{JA}}$ | Thermal Resistance, Junction to Ambient | 62.5 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |  |
|  |  |  | 62.5 |  |

Package Marking and Ordering Information $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise noted

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
| :---: | :---: | :---: | :---: | :---: | :---: |
| FDP5N50U | FDP5N50U | TO-220 | - | - | 50 |
| FDPF5N50UT | FDPF5N50UT | TO-220F | - | - | 50 |

Electrical Characteristics

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Off Characteristics |  |  |  |  |  |  |
| $\mathrm{BV}_{\text {DSS }}$ | Drain to Source Breakdown Voltage | $\mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ | 500 | - | - | V |
| $\frac{\Delta \mathrm{BV}_{\mathrm{DSS}}}{\Delta \mathrm{~T}_{\mathrm{J}}}$ | Breakdown Voltage Temperature Coefficient | $\mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$, Referenced to $25^{\circ} \mathrm{C}$ | - | 0.7 | - | V/ $/{ }^{\circ} \mathrm{C}$ |
| ${ }^{\text {DSS }}$ | Zero Gate Voltage Drain Current | $\mathrm{V}_{\mathrm{DS}}=500 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | - | - | 25 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{DS}}=400 \mathrm{~V}, \mathrm{~T}_{\mathrm{C}}=125^{\circ} \mathrm{C}$ | - | - | 250 |  |
| $\mathrm{I}_{\text {GSS }}$ | Gate to Body Leakage Current | $\mathrm{V}_{\mathrm{GS}}= \pm 30 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ | - | - | $\pm 100$ | nA |

On Characteristics

| $\mathrm{V}_{\mathrm{GS}(\mathrm{th})}$ | Gate Threshold Voltage | $\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 3 | - | 5 | V |
| :--- | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | Static Drain to Source On Resistance | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=2 \mathrm{~A}$ | - | 1.65 | 2 | $\Omega$ |
| $\mathrm{~g}_{\mathrm{FS}}$ | Forward Transconductance | $\mathrm{V}_{\mathrm{DS}}=40 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=2 \mathrm{~A} \quad($ Note 4) | - | 4.8 | - | S |

## Dynamic Characteristics

| $\mathrm{C}_{\text {iss }}$ | Input Capacitance | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=25 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V} \\ & \mathrm{f}=1 \mathrm{MHz} \end{aligned}$ |  | - | 485 | 650 | pF |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{C}_{\text {oss }}$ | Output Capacitance |  |  | - | 65 | 90 | pF |
| $\mathrm{C}_{\text {rss }}$ | Reverse Transfer Capacitance |  |  | - | 5 | 8 | pF |
| $\mathrm{Q}_{\mathrm{g} \text { (tot) }}$ | Total Gate Charge at 10V | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=400 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=4 \mathrm{~A} \\ & \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V} \end{aligned}$ | (Note 4, 5) | - | 11 | 15 | nC |
| $\mathrm{Q}_{\mathrm{gs}}$ | Gate to Source Gate Charge |  |  | - | 3 | - | nC |
| $\mathrm{Q}_{\mathrm{gd}}$ | Gate to Drain "Miller" Charge |  |  | - | 5 | - | nC |

## Switching Characteristics

| $\mathrm{t}_{\mathrm{d} \text { (on) }}$ | Turn-On Delay Time | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=250 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=4 \mathrm{~A} \\ & \mathrm{R}_{\mathrm{G}}=25 \Omega \end{aligned}$ | (Note 4, 5) | - | 14 | 38 | ns |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{r}}$ | Turn-On Rise Time |  |  | - | 21 | 52 | ns |
| $\mathrm{t}_{\mathrm{d} \text { (off) }}$ | Turn-Off Delay Time |  |  | - | 27 | 64 | ns |
| $\mathrm{t}_{\mathrm{f}}$ | Turn-Off Fall Time |  |  | - | 20 | 50 | ns |

## Drain-Source Diode Characteristics

| $\mathrm{I}_{\text {S }}$ | Maximum Continuous Drain to Source Diode Forward Current |  |  | - | - | 4 | A |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\text {SM }}$ | Maximum Pulsed Drain to Source Diode Forward Current |  |  | - | - | 16 | A |
| $\mathrm{V}_{\text {SD }}$ | Drain to Source Diode Forward Voltage | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{SD}}=4 \mathrm{~A}$ |  | - | - | 1.6 | V |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse Recovery Time | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{SD}}=4 \mathrm{~A}$ |  | - | 36 | - | ns |
| $\mathrm{Q}_{\text {rr }}$ | Reverse Recovery Charge | $\mathrm{dl}_{\mathrm{F}} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$ | (Note 4) | - | 33 | - | nC |

## Notes

1: Repetitive Rating: Pulse width limited by maximum junction temperature
: $L=27 \mathrm{mH}, \mathrm{I}_{\mathrm{AS}}=4 \mathrm{~A}, \mathrm{~V}_{\mathrm{DD}}=50 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=25 \Omega$, Starting $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$
3: $\mathrm{I}_{\mathrm{SD}} \leq 4 \mathrm{~A}, \mathrm{di} / \mathrm{dt} \leq 200 \mathrm{~A} / \mu \mathrm{s}, \mathrm{V}_{\mathrm{DD}} \leq \mathrm{BV}_{\mathrm{DSS}}$, Starting $\mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C}$
4: Pulse Test: Pulse width $\leq 300 \mu \mathrm{~s}$, Duty Cycle $\leq 2 \%$
5: Essentially Independent of Operating Temperature Typical Characteristics

## Typical Performance Characteristics

Figure 1. On-Region Characteristics


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage


Figure 5. Capacitance Characteristics


Figure 2. Transfer Characteristics


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature


Figure 6. Gate Charge Characteristics


